

Search Notes

Application/Control No.

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Examiner

David E. Bochna

Applicant(s)/Patent under
Reexamination

INOUE ET AL.

Art Unit

3679

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
285	319	1/30/2006	
	93		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated the previous search	1/30/2006	DB